# <u>Silicon Carbide (SiC)</u> <u>MOSFET</u> – EliteSiC, 80 mohm, 1200 V, M1, D2PAK-7L

# NTBG080N120SC1

### Features

- Typ.  $R_{DS(on)} = 80 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ.  $Q_{G(tot)} = 56 \text{ nC}$ )
- Low Effective Output Capacitance (Typ. C<sub>oss</sub> = 79 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

# Typical Applications

- UPS
- DC-DC Converter
- Boost Inverter

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

	Parameter	Symbol	Value	Unit
Drain-to-So	irce Voltage	V <sub>DSS</sub>	1200	V
Gate-to-Sou	rce Voltage	V <sub>GS</sub>	-15/+25	V

#### Table 1. THERMAL CHARACTERISTICS

Parameter	Symbol	Мах	Unit
Thermal Resistance Junction-to-Case (Note 1)	$R_{ extsf{ heta}JC}$	0.84	°C/W
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	40	°C/W

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parameter	Symbol Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 1 mA$	1200			V

Drain-to-Source Breakdown Voltage

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit			
DRAIN SOURCE DIODE CHARACTERISTICS									
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5/20 \text{ V}, I_{SD} = 20 \text{ A}, dI_S/dt = 1000 \text{ A}/\mu \text{s}$		16.2		ns			
Reverse Recovery Charge	Q <sub>RR</sub>			61.6		nC			
Reverse Recovery Energy	E <sub>REC</sub>			4.1		μJ			
Peak Reverse Recovery Current	I <sub>RRM</sub>			7.6		А			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# **TYPICAL CHARACTERISTICS**

#### Figure 1. On Region Characteristics



TJ, JUNCTION TEMPERATURE (°C)



V<sub>GS</sub>, GATE–TO–

Figure 5. Transfer Characteristics

### Figure 2. Normalized On Resistance vs. Drain Current and Gate Voltage



# Figure 4. On Resistance vs. Gate to Source Voltage



Figure 6. Diode Forward Voltage vs. Current

#### D<sup>2</sup>PAK7 (TO-263-7L HV) CASE 418BJ ISSUE B

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c2

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DATE 16 AUG 2019



\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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